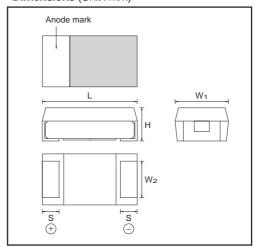
# Chip tantalum capacitors (Fail-safe open structure type)

# **TCFG Series A Case**

#### Features

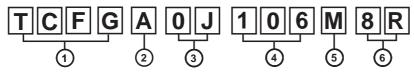
- 1) Safety design by open function built in.
- 2) Wide capacitance range
- 3) Screening by thermal shock.

# ●Dimensions (Unit:mm)



Case code	L	W <sub>1</sub>	W <sub>2</sub>	Н	S
A 3216-18(1206)	3.2±0.2	1.6±0.2	1.2±0.2	1.6±0.2	0.8±0.3

#### ●Part No. Explanation



- 1 Series name
- 2 Case code
- 3 Rated voltage

Rated voltage (V)	4	6.3	10	16	20	25
CODE	0G	0J	1A	1C	1D	1E

(4) Capacitance

Nominal capacitance in pF in 3 digits: 2 significant figure representing the number of 0's.

5 Capacitance tolerance

M: ±20% K: ±10%

- 6 Taping
  - 8 : Tape width (8mm)
  - R : Positive electrode on the side opposite to sprocket hole

#### ● Capacitance range

TCFG series A Case

			Rated vo	Itage (V)		
(μF)	4 G	6.3 J	10 A	16 C	20 D	25 E
1.0 (105)				А	А	А
1.5 (155)			А	Α 🛭	Vew A A	<i>lew</i> /A
2.2 (225)			Α	Α Λ	lew A M	<i>ew</i> A
3.3 (335)		А	А	А	А	Α
4.7 (475)	А	А	А	А	А	Α
6.8 (685)	А	А	Α	А		
10 (106)	А	А	А	А		
15 (156)	А	А	А			
22 (226)	А	А	Α			
33 (336)	А	А				
47 (476)	А	А				
68 (686)	А					

Remark) Case size codes (A) in the above show each size products line-up.

New : Indicates new product

#### Marking

The indications listed below should be given on the surface of a capacitor.

- ① Polarity : The polarity should be shown by □bar. (on the anode side)
- ② Rated DC voltage: Due to the small size of A case, a voltage code is used as shown below.
- ③ Visual typical example (1)voltage code (2) capacitance code

[A Case] note 1) 
$$\frac{J}{(1)} \frac{106}{(2)}$$



note 2) voltage code and capacitance code are variable with parts number

#### Characteristics

Item	1	Performance			orma	nce	Test conditions (based on JIS C5101-1 and JIS C5101-3)				
Operating Tem	Operating Temperature					Voltage reduction when temperature exceeds +85°C					
Maximum operatin with no voltage de		+8	5 °C								
Rated Voltage	(V.DC)	4	6.3	10	16	20	25		at 85°C		
Category Volta	ge (V.DC)	2.5	4	6.3	10	13	16		at 125°C		
Surge Voltage		5.0	8	13	20	26	32		at 85°C		
DC leakage cui	rent			or 0.0′ n in "S				er is greater	As per 4.9 JIS C 5101-1 As per 4.5.1 JIS C 5101-3 Voltage : Rated voltage for 1min		
Capacitance to	lerance	I .		e satis ±20%	isfied allowance range. %			e range.	As per 4.7 JIS C 5101-1 As per 4.5.2 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V.DC Measuring circuit : DC Equivalent series circuit		
Tangent of loss (Df, tanδ)	Tangent of loss angle (Df, tanδ)  Shall be satisfied the voltage on "Standard list"				e on "Standard list"	As per 4.8 JIS C 5101-1 As per 4.5.3 JIS C 5101-3 Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms, +1.5V.DC Measuring circuit : DC Equivalent series circuit					
Impedance	npedance Shall be satisfied the voltage on "Standard list"			As per 4.10 JIS C 5101-1 As per 4.5.4 JIS C 5101-3 Measuring frequency : 100±10kHz Measuring voltage : 0.5Vrms or less							
Resistance to soldering heat	Appearance		There should be no significant abnormality. The indications should be clear.			As per 4.14 JIS C 5101-1 As per 4.6 JIS C 5101-3					
	L.C	Les	ss tha	an initi	ial li	imit			Dip in the solder bath Solder temp : 260±5°C		
	ΔC / C	Wit	Within ±5% of initial value			alue		Duration : 5±0.5s			
	tanδ	Les	ss tha	an initi	ial li	imit			Repetition : 1 After the specimens, leave it at room temperature fover 24h and then measure the sample.  Dip in the solder bath Solder temp: 320±5°C		
Fail-Safe open	unit actuation	Wit	thin 3	320°C	; — ;	20s					
Temperature cycle	Appearance			hould ication				ant abnormality. clear.	As per 4.16 JIS C 5101-1 As per 4.10 JIS C 5101-3		
	L.C	Les	ss tha	an initi	al li	mit			Repetition: 5 cycles (1 cycle: steps 1 to 4) without discontinuation.		
ΔC / C		TCFGA1A226□ :±15% TCFGA0J476□ :±15% TCFGA0G686□ :±15% Others :±10%			Step         Temp.         Time           1         −55±3°C         30±3min           2         Room temp.         3min. or less						
	tanδ Less than initial limit			3 125±2°C 30±3min 4 Room temp. 3min. or less  After the specimens, leave it at room temperature fover 24h and then measure the sample.							
Moisture resistance	Appearance	l .		hould				ant abnormality. clear.	As per 4.12 JIS C 5101-1 As per 4.12 JIS C 5101-3		
	L.C	Les	ss tha	an initi	al li	imit			After leaving the sample under such atmospheric		
		Less than initial limit  Within ±10% of initial value					condition that the temperature and humidity are				
	∆C / C	Wit	thin ±	10%	Of I	nıtıal	valu	е	60±2°C and 90 to 95%RH, respectively, for		

# Tantalum capacitors

Item		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)			
Temperature Stability	Temp.	−55°C	As per 4.29 JIS C 5101-1 As per 4.13 JIS C 5101-3			
ΔC / C		Within 0/–12%of initial value	-			
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	_				
	Temp.	+85°C				
	ΔC / C	Within +10/0%of initial value				
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	5μA or 0.1CV whichever is greater				
	Temp.	+125°C				
	ΔC / C	Within +15/0%of initial value				
	tanδ	Shall be satisfied the voltage on "Standard list"				
	L.C	6.3μA or 0.125CV whichever is greater				
Surge Voltage	Appearance	There should be no significant abnormality. The indications should be clear.	As per 4.26 JIS C 5101-1 As per 4.14 JIS C 5101-3			
	L.C	Less than initial limit	Apply the specified surge voltage every 5±0.5mi			
	ΔC / C	Within ±10%of initial value	<ul> <li>for 30±5 s. each time in the atmospheric condit of 85±2°C.</li> <li>Repeat this procedure 1,000 times.</li> <li>After the specimens, leave it at room tempera for over 24h and then measure the sample.</li> </ul>			
	tanδ	Less than initial limit	101 Over 2411 and then measure the sample.			
Loading at High	Appearance	There should be no significant abnormality. The indications should be clear.	As per 4.23 JIS C 5101-1 As per 4.15 JIS C 5101-3			
temperature	L.C	Less than initial limit	After applying the rated voltage for 2000+72/0			
	ΔC / C	TCFGA1A226 : ±15% TCFGA0J476 : ±15% TCFGA0G686 : ±15% Others : ±10%	without discontinuation via the serial resistan of $3\Omega$ or less at a temperature of $85\pm2^{\circ}$ C, lea the sample at room temperature/humidity for over 24h and measure the value.			
	tanδ	Less than initial limit				
Terminal	Capacitance	The measured value should be stable.	As per 4.35 JIS C 5101-1			
Strength	Appearance	There should be no significant abnormality.	As per 4.9 JIS C 5101-3 A force is applied to the terminal until it bends to 1mm and by a prescribed tool maintain the condition for 5s. (See the figure below.)  Thickness 1.6mm			
Adhesivene	ess	The terminal should not come off.	As per 4.34 JIS C 5101-1 As per 4.8 JIS C 5101-3 Apply force of 5N in the two directions shown in the figure below for 10±1s after mounting the terminal on a circuit board.  product  Apply force a circuit board			

# Tantalum capacitors

Item		Performance	Test conditions (based on JIS C5101-1 and JIS C5101-3)
Dimension	ns	Be based on "External dimensions"	Measure using a caliper of JIS B 7505 Class 2 or higher grade.
Resistance to solvents		The indication should be clear.	As per 4.32 JIS C 5101-1 As per 4.18 JIS C 5101-3 Dip in the isopropyl alcohol for 30±5s, at room temperature.
Solderability		3/4 or more surface area of the solder coated terminal dipped in the soldering bath should be covered with the new solder.	As per 4.15.2 JIS C 5101-1 As per 4.7 JIS C 5101-3 Dip speed = 25±2.5mm/s Pre-treatment (accelerated aging): Leave the sample on the boiling distilled water for 1h. Solder temp.: 245±5°C Duration: 3±0.5s Solder: M705 Flux: Rosin 25%, IPA 75%
Vibration	Capacitance	The measured value should be stable.	As per 4.17 JIS C 5101-1 Frequency : 10 to 55 to 10Hz/min.
	Appearance	There should be no significant abnormality.	Amplitude: 1.5mm Time: 2h each in X and Y directions Mounting: The terminal is soldered on a print circuit board.

## ●Standard list, TCFG series A Cases

(A: 3216)

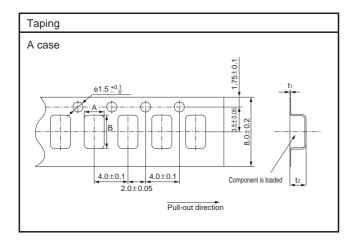
										(A :	3216)
Part No.	Rated Voltage @85°C	Derated Voltage @125°C	Surge Voltage @85°C	Capacitance Tolerance		Leakage current 25°C	D	F 120H (%)	łz	Impedance 100kHz	Case
	(V)	(V)	(V)	(μF)	(%)	1WV.60s (μA)	–55°C	25°C 85°C	125°C	(Ω)	code
TCFG A 0G 475□	4	2.5	5	4.7	±20, ±10	0.5	10	6	8	5.6	Α
TCFG A 0G 685 □	4	2.5	5	6.8	±20, ±10	0.5	12	8	10	4.9	Α
TCFG A 0G 106 □	4	2.5	5	10	±20, ±10	0.5	12	8	10	4.2	Α
TCFG A 0G 156 □	4	2.5	5	15	±20, ±10	0.6	12	8	10	4.0	Α
TCFG A 0G 226□	4	2.5	5	22	±20, ±10	0.9	12	8	10	3.0	Α
TCFG A 0G 336 □	4	2.5	5	33	±20, ±10	1.3	14	10	12	3.5	Α
TCFG A 0G 476 □	4	2.5	5	47	±20, ±10	1.9	30	12	16	3.2	Α
TCFG A 0G 686 □	4	2.5	5	68	±20, ±10	3.0	32	16	20	3.0	Α
TCFG A 0J 335 □	6.3	4	8	3.3	±20, ±10	0.5	10	6	8	5.6	Α
TCFG A 0J 475 □	6.3	4	8	4.7	±20, ±10	0.5	12	8	10	4.9	Α
TCFG A 0J 685 □	6.3	4	8	6.8	±20, ±10	0.5	12	8	10	4.2	Α
TCFG A 0J 106 □	6.3	4	8	10	±20, ±10	0.6	12	8	10	4.0	Α
TCFG A 0J 156□	6.3	4	8	15	±20, ±10	0.9	12	8	10	3.0	Α
TCFG A 0J 226□	6.3	4	8	22	±20, ±10	1.4	14	10	12	3.5	Α
TCFG A 0J 336□	6.3	4	8	33	±20, ±10	2.1	30	12	16	3.2	Α
TCFG A 0J 476□	6.3	4	8	47	±20, ±10	3.0	34	18	24	3.2	Α
TCFG A 1A 155 🗆	10	6.3	13	1.5	±20, ±10	0.5	10	6	8	8.8	Α
TCFG A 1A 225□	10	6.3	13	2.2	±20, ±10	0.5	10	6	8	5.6	Α
TCFG A 1A 335 □	10	6.3	13	3.3	±20, ±10	0.5	12	8	10	4.9	Α
TCFG A 1A 475 □	10	6.3	13	4.7	±20, ±10	0.5	12	8	10	4.2	Α
TCFG A 1A 685 □	10	6.3	13	6.8	±20, ±10	0.7	12	8	10	4.0	Α
TCFG A 1A 106 □	10	6.3	13	10	±20, ±10	1.0	12	8	10	3.0	Α
TCFG A 1A 156 □	10	6.3	13	15	±20, ±10	1.5	14	10	12	3.5	Α
TCFG A 1A 226 □	10	6.3	13	22	±20, ±10	2.2	30	12	16	3.2	Α
TCFG A 1C 105 □	16	10	20	1.0	±20, ±10	0.5	10	6	8	7	Α
TCFG A 1C 155 □	16	10	20	1.5	±20, ±10	0.5	10	6	8	5.6	Α
TCFG A 1C 225 □	16	10	20	2.2	±20, ±10	0.5	10	6	8	4.9	Α
TCFG A 1C 335 □	16	10	20	3.3	±20, ±10	0.5	10	6	8	4.8	Α
TCFG A 1C 475 □	16	10	20	4.7	±20, ±10	0.8	10	6	8	3.9	Α
TCFG A 1C 685 □	16	10	20	6.8	±20, ±10	1.1	10	6	8	3.8	Α
TCFG A 1C 106 □	16	10	20	10	±20, ±10	1.6	12	8	10	3.5	Α
TCFG A 1D 105 □	20	13	26	1.0	±20, ±10	0.5	10	6	8	7	Α
TCFG A 1D 155 □	20	13	26	1.5	±20, ±10	0.5	10	6	8	6.0	Α
TCFG A 1D 255 □	20	13	26	2.2	±20, ±10	0.5	10	6	8	5.2	Α
TCFG A 1D 335 □	20	13	26	3.3	±20, ±10	0.7	10	6	8	4.8	Α
TCFG A 1D 475 □	20	13	26	4.7	±20, ±10	0.9	10	6	8	3.9	Α
TCFG A 1E 105 □	25	16	32	1.0	±20, ±10	0.5	8	6	8	7	А
TCFG A 1E 155 □	25	16	32	1.5	±20, ±10	0.5	10	6	8	6.0	Α
TCFG A 1E 255 □	25	16	32	2.2	±20, ±10		10	6	8	5.2	Α
TCFG A 1E 335 □	25	16	32	3.3	±20, ±10		10	6	8	4.8	A
TCFG A 1E 475	25	16	32	4.7	±20, ±10		12	8	10	3.4	A
			J-		,					Ü. i	

 $\square$  =Tolerance (M : ±20%, K : ±10%)



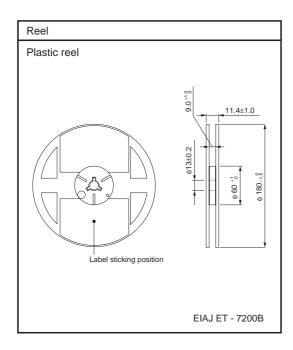
# Packaging specifications

Case code	A±0.1	B±0.1	t1±0.05	t2±0.1
A (3216)	1.9	3.5	0.25	1.9



## Packaging style

Case code	Packaging	Packag	ing style	Symbol	Basic ordering unit
A Case	Taping	Plastic taping	φ180mm reel	R	2,000



Rev.D

#### Recommended condition of reflow soldering

#### (1) Leakage current-to-voltage ratio

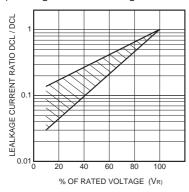
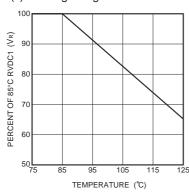


Fig.1

#### (2) Derating voltage as function of temperature



85	5°C	125	5°C
Rated Voltage	Surge Voltage	Category Voltage	Surge Voltage
(V.DC)	(V.DC)	(V.DC)	(V.DC)
4	5.0	2.5	3.2
6.3	8	4	5
10	13	6.3	8
16	20	10	13
20	26	13	16
25	32	16	20

Fig.2

## (3) Reliability

The malfunction rate of tantalum solid state electrolytic capacitors varies considerably depending on the conditions of usage (ambient temperature, applied voltage, circuit resistance).

#### Formula for calculating malfunction rate

 $\lambda p = \lambda b \times (\pi E \times \pi SR \times \pi Q \times \pi CV)$ 

 $\lambda p$   $\;\;$  : Malfunction rate stemming from operation

 $\begin{array}{lll} \lambda b & : \mbox{Basic malfunction rate} \\ \pi E & : \mbox{Environmental factors} \\ \pi S R & : \mbox{Series resistance} \\ \pi \Omega & : \mbox{Level of malfunction rate} \\ \end{array}$ 

 $\pi cv$ : Capacitance

For details on how to calculate the malfunction rate stemming from operation, see the tantalum solid state electrolytic capacitors column in MIL-HDBK-217.



Malfunction rate as function of operating temperature and rated voltage

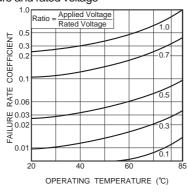


Fig.3

Malfunction rate as function of circuit resistance ( $\Omega$ /V)

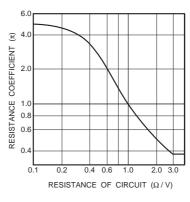
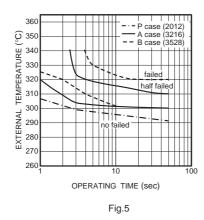


Fig.4

(4) External temperature vs. fuse blowout



(5) Power vs. fuse blowout characteristics / Product surface temperature

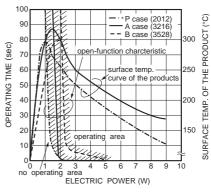


Fig.6

Note: Solder the chip at 300°C or less. If it is soldered using a temperature higher than 300°C, open function built-in may operate.

#### (6) Maximum power dissipation

Warming of the capacitor due to ripple voltage balances with warming caused by Joule heating and by radiated heat. Maximum allowable warming of the capacitor is to 5°C above ambient temperature. When warming exceeds 5°C, it can damage the dielectric and cause a short circuit.

Power dissipation (P) =  $I^2 \cdot R$ 

Ripple current

P: As shown in table at right

R: Equivalent series resistance

#### Notes:

- 1. Please be aware that when case size is changed, maximum allowable power dissipation is reduced.
- 2. Maximum power dissipation varies depending on the package. Be sure to use a case which will keep warming within the limits shown in the table below.

## Allowable power dissipation (W) and maximum temperature rising

Case Ambient temp	+25°C	+55°C	+85°C	+125°C
A case (3216)	0.070	0.063	0.056	0.028
Max. Temp Rise[°C]	5	5	5	2

#### (7) Impedance frequency characteristics

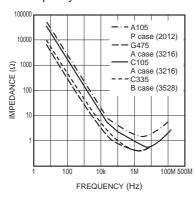


Fig.7

#### (8) ESR frequency characteristics

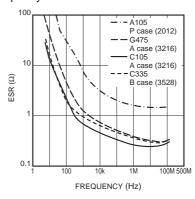
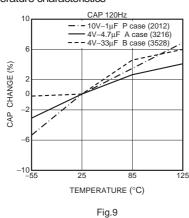


Fig.8

# (9) Temperature characteristics



DF 120Hz

---10V-1μF P case (2012)
---4V-4.7μF A case (3216)
---4V-33μF B case (3528)

3

2

1

0

-55

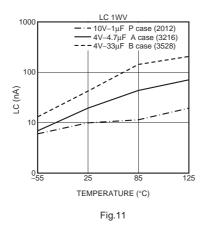
25

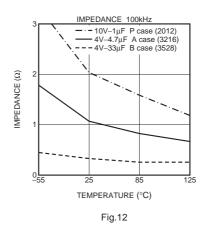
85

125

TEMPERATURE (°C)

Fig.10





#### Inrush current

Beware of inrush curren

Inrush currents are inversely proportional ESR. Large inrush currents can cause components failure.

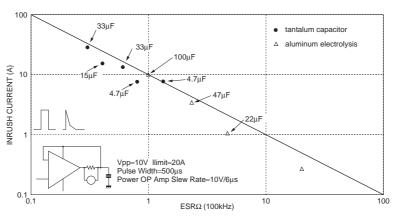


Fig. 13 Maximum inrush current and ESR

Inrush current can be limited by means of a protective resistor.

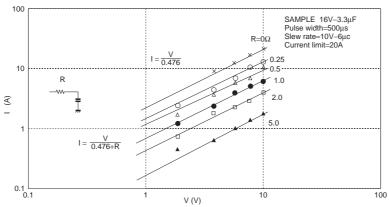


Fig. 14 Imax change due to protective resistor R

# Tantalum capacitors

#### (10) Ultrasonic cleaning

Carry out cleaning under as mild conditions as possible. The internal element of a tantalum capacitor are larger than those of a transistor or diode, so it is not as resistant as ultrasonic waves.

Example: water

Propagation speed 1500m/s Solvent density 1g/cm<sup>3</sup>

#### Frequency and wavelength

Frequency	Wavelength
20kHz	7.5cm
28kHz	5.3cm
50kHz	3.0cm

#### Precautions

- 1) Do not allow solvent to come to a boil (kinetic energy increases).
- . Ultrasonic output 0.5W / cm<sup>2</sup> or less
- . Use a solvent with a high boiling point.
- . Lower solvent temperature.
- 2) Ultrasonic cleaning frequency 28 kHz or less
- 3) Keep cleaning time as short as possible.
- 4) Move item being cleaned.

Standing waves caused by the ultrasonic waves can cause stress to build up in part of the item being cleaned.

#### Reference

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ROHM CO., LTD. 21, Saiin Mizosaki-cho, Ukyo-ku, Kyoto 615-8585, Japan

an TEL:+81-75-311-2121 FAX:+81-75-315-0172

